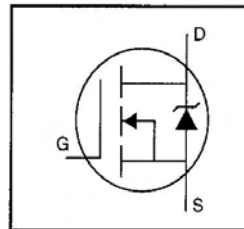


IRLZ24PbF

HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Logic-Level Gate Drive
- RDS(on) Specified at VGS=4V & 5V
- 175°C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Lead-Free

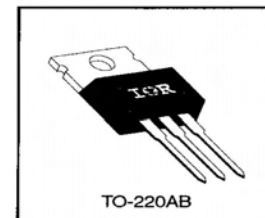


$V_{DSS} = 60V$
 $R_{DS(on)} = 0.10\Omega$
 $I_D = 17A$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



Absolute Maximum Ratings

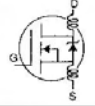
| | Parameter | Max. | Units |
|---------------------------|--|-----------------------|-------|
| $I_D @ T_C = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 5.0 V$ | 17 | A |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 5.0 V$ | 12 | |
| I_{DM} | Pulsed Drain Current ① | 68 | |
| $P_D @ T_C = 25^\circ C$ | Power Dissipation | 60 | W |
| | Linear Derating Factor | 0.40 | W/°C |
| V_{GS} | Gate-to-Source Voltage | ± 10 | V |
| E_{AS} | Single Pulse Avalanche Energy ② | 110 | mJ |
| dv/dt | Peak Diode Recovery dv/dt ③ | 4.5 | V/ns |
| T_J T_{STG} | Operating Junction and Storage Temperature Range | -55 to +175 | °C |
| | Soldering Temperature, for 10 seconds | 300 (1.6mm from case) | |
| | Mounting Torque, 6-32 or M3 screw | 10 lbf•in (1.1 N•m) | |

Thermal Resistance

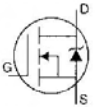
| | Parameter | Min. | Typ. | Max. | Units |
|-----------------|-------------------------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | — | — | 2.5 | °C/W |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | — | 0.50 | — | |
| $R_{\theta JA}$ | Junction-to-Ambient | — | — | 62 | |

IRLZ24PbF

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|---------------------------------|--------------------------------------|------|-------|------|--------------------|---|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage | 60 | — | — | V | $V_{GS}=0V, I_D=250\mu A$ |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | — | 0.060 | — | $V/^\circ\text{C}$ | Reference to $25^\circ\text{C}, I_D=1\text{mA}$ |
| $R_{DS(on)}$ | Static Drain-to-Source On-Resistance | — | — | 0.10 | Ω | $V_{GS}=5.0V, I_D=10A$ ④ |
| | | — | — | 0.14 | | $V_{GS}=4.0V, I_D=8.5A$ ④ |
| $V_{GS(th)}$ | Gate Threshold Voltage | 1.0 | — | 2.0 | V | $V_{DS}=V_{GS}, I_D=250\mu A$ |
| g_{fs} | Forward Transconductance | 7.3 | — | — | S | $V_{DS}=25V, I_D=10A$ ④ |
| I_{DSS} | Drain-to-Source Leakage Current | — | — | 25 | μA | $V_{DS}=60V, V_{GS}=0V$ |
| | | — | — | 250 | | $V_{DS}=48V, V_{GS}=0V, T_J=150^\circ\text{C}$ |
| I_{GSS} | Gate-to-Source Forward Leakage | — | — | 100 | nA | $V_{GS}=10V$ |
| | Gate-to-Source Reverse Leakage | — | — | -100 | | $V_{GS}=-10V$ |
| Q_g | Total Gate Charge | — | — | 18 | nC | $I_D=17A$ |
| Q_{gs} | Gate-to-Source Charge | — | — | 4.5 | | $V_{DS}=48V$ |
| Q_{gd} | Gate-to-Drain ("Miller") Charge | — | — | 12 | | $V_{GS}=5.0V$ See Fig. 6 and 13 ④ |
| $t_{d(on)}$ | Turn-On Delay Time | — | 11 | — | | $V_{DD}=30V$ |
| t_r | Rise Time | — | 110 | — | ns | $I_D=17A$ |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 23 | — | | $R_G=9.0\Omega$ |
| t_f | Fall Time | — | 41 | — | | $R_D=1.7\Omega$ See Figure 10 ④ |
| L_D | Internal Drain Inductance | — | 4.5 | — | nH | Between lead, 6 mm (0.25in.) from package and center of die contact  |
| L_S | Internal Source Inductance | — | 7.5 | — | | |
| C_{iss} | Input Capacitance | — | 870 | — | pF | $V_{GS}=0V$ |
| C_{oss} | Output Capacitance | — | 360 | — | | $V_{DS}=25V$ |
| C_{riss} | Reverse Transfer Capacitance | — | 53 | — | | $f=1.0\text{MHz}$ See Figure 5 |

Source-Drain Ratings and Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|----------|--|---|------|------|---------------|--|
| I_S | Continuous Source Current (Body Diode) | — | — | 17 | A | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I_{SM} | Pulsed Source Current (Body Diode) ① | — | — | 68 | | |
| V_{SD} | Diode Forward Voltage | — | — | 1.5 | V | $T_J=25^\circ\text{C}, I_S=17A, V_{GS}=0V$ ④ |
| t_{rr} | Reverse Recovery Time | — | 110 | 260 | ns | $T_J=25^\circ\text{C}, I_F=17A$ |
| Q_{rr} | Reverse Recovery Charge | — | 0.49 | 1.5 | μC | $di/dt=100A/\mu\text{s}$ ④ |
| t_{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D) | | | | |

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ② $V_{DD}=25V$, starting $T_J=25^\circ\text{C}$, $L=444\mu\text{H}$, $R_G=25\Omega$, $I_{AS}=17A$ (See Figure 12)
- ③ $I_{SD}\leq 17A$, $di/dt\leq 140A/\mu\text{s}$, $V_{DD}\leq V_{(BR)DSS}$, $T_J\leq 175^\circ\text{C}$
- ④ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

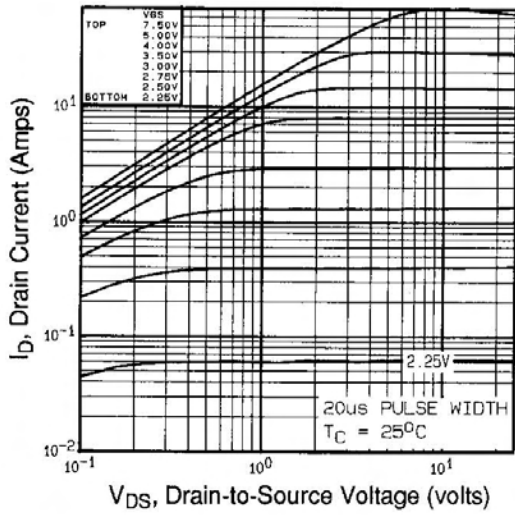


Fig 1. Typical Output Characteristics,
 $T_C=25^{\circ}\text{C}$

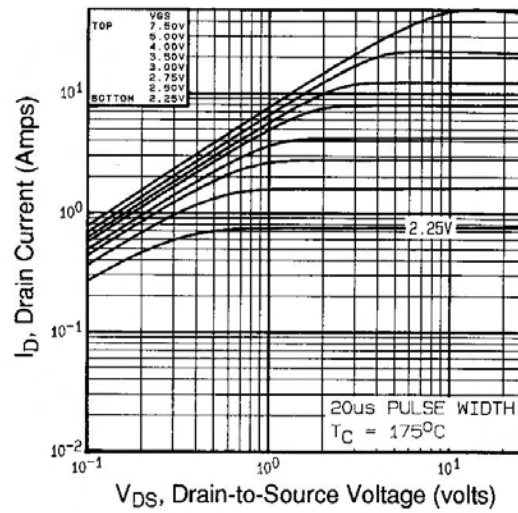


Fig 2. Typical Output Characteristics,
 $T_C=175^{\circ}\text{C}$

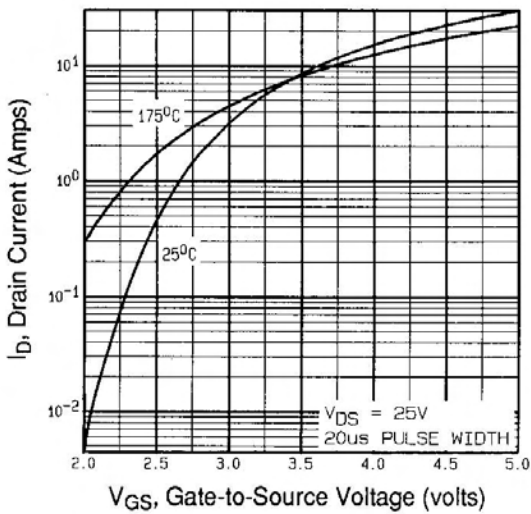


Fig 3. Typical Transfer Characteristics

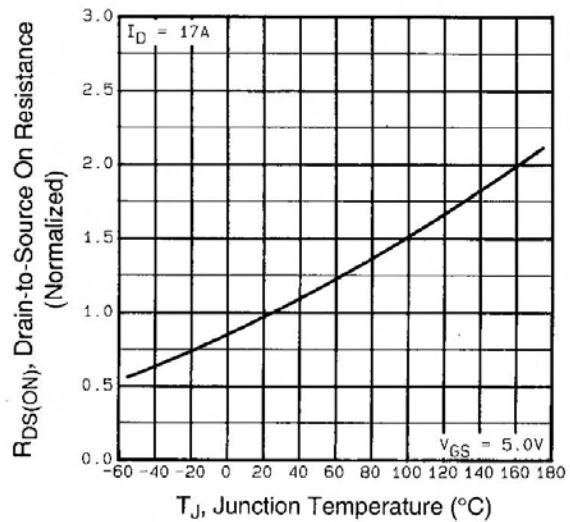


Fig 4. Normalized On-Resistance
Vs. Temperature

IRLZ24PbF

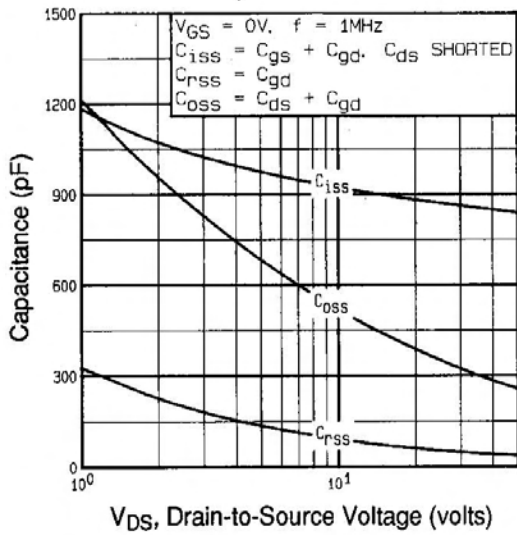


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

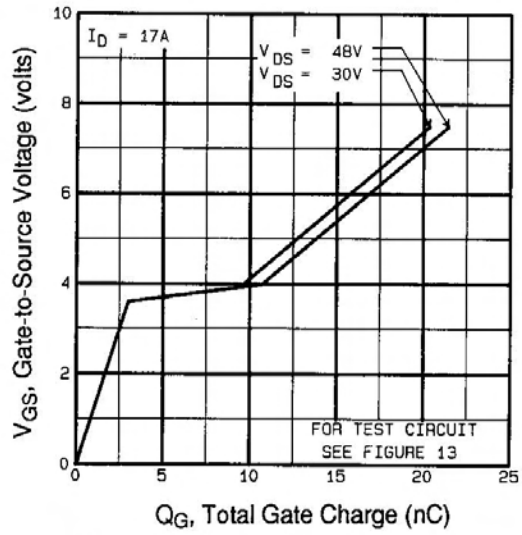


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

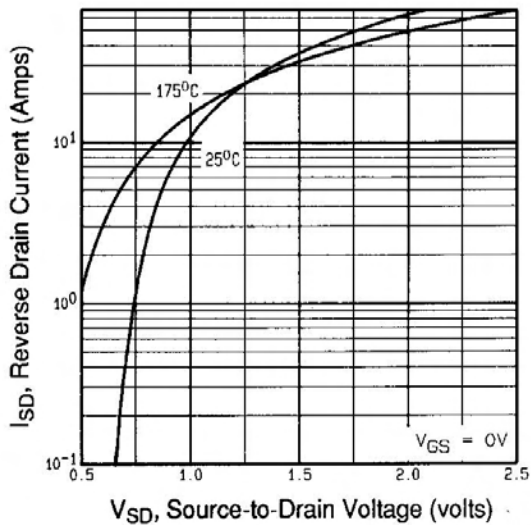


Fig 7. Typical Source-Drain Diode Forward Voltage

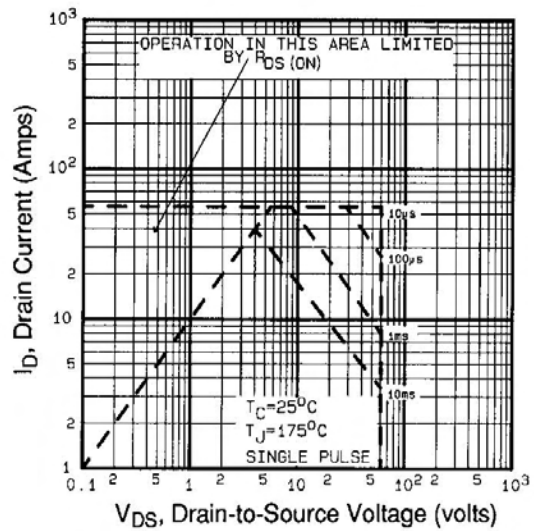


Fig 8. Maximum Safe Operating Area

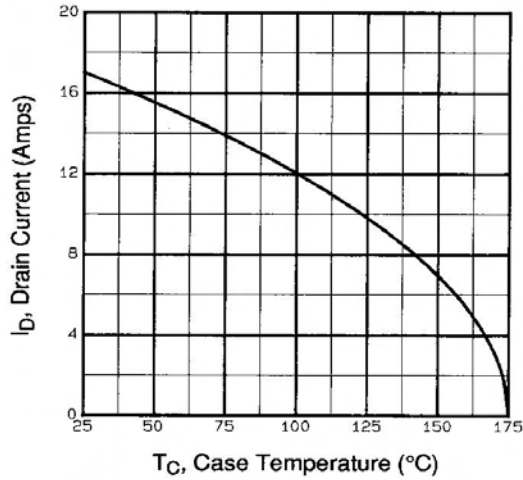


Fig 9. Maximum Drain Current Vs. Case Temperature

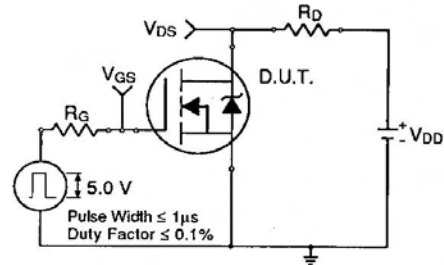


Fig 10a. Switching Time Test Circuit

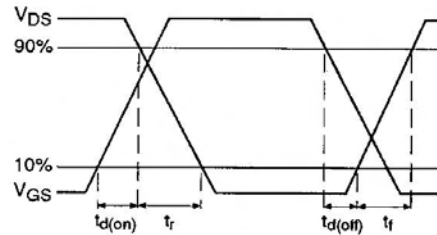


Fig 10b. Switching Time Waveforms

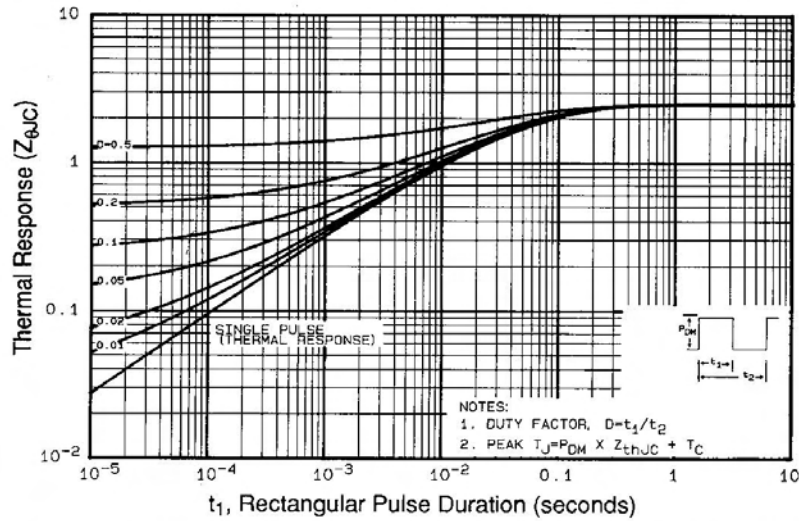


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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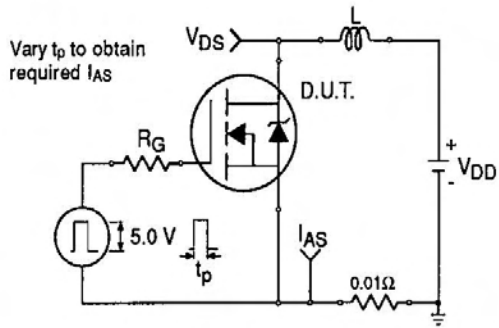


Fig 12a. Unclamped Inductive Test Circuit

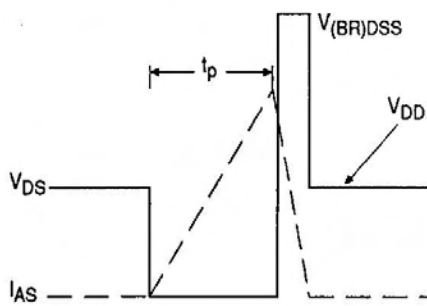


Fig 12b. Unclamped Inductive Waveforms

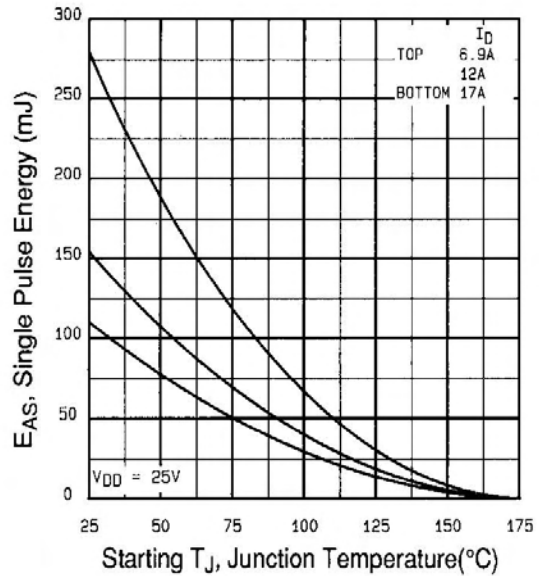


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

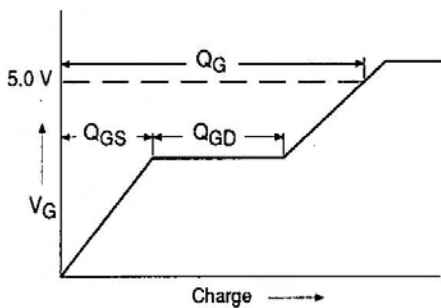


Fig 13a. Basic Gate Charge Waveform

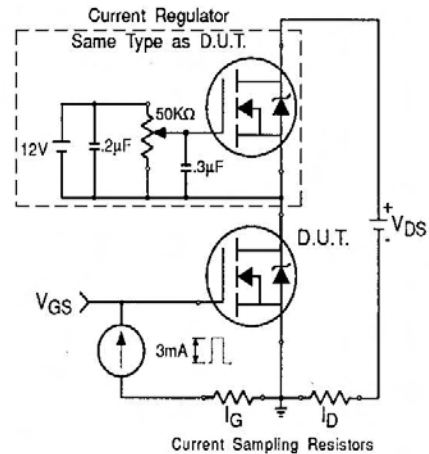
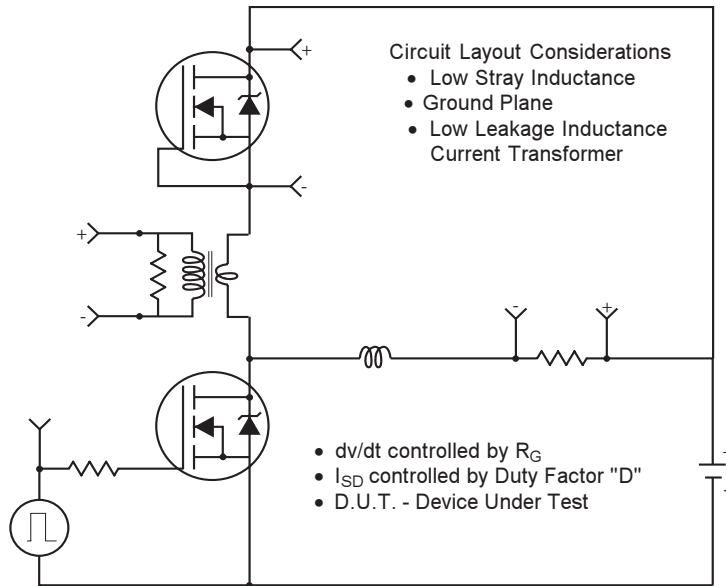
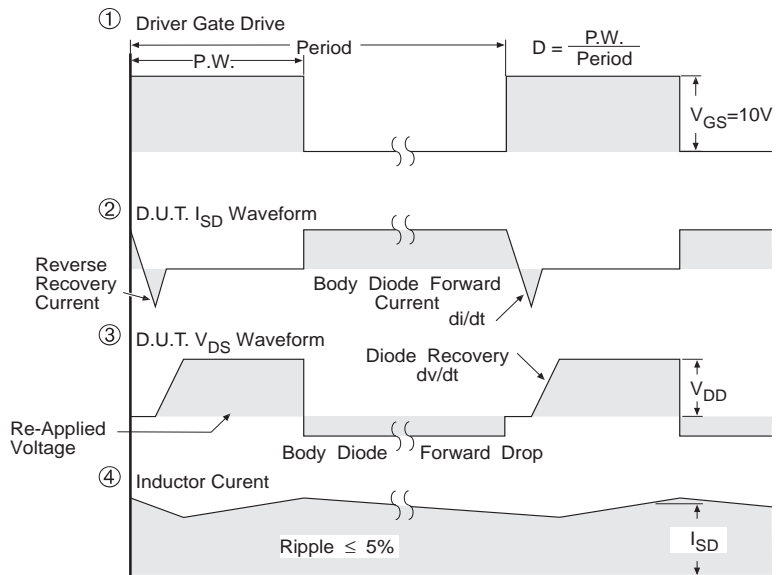


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



- * Reverse Polarity for P-Channel
- ** Use P-Channel Driver for P-Channel Measurements



*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

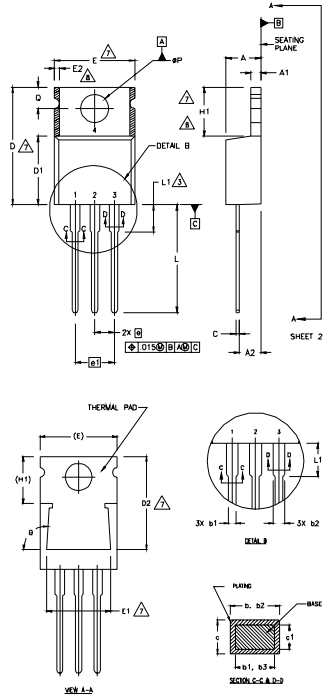
Fig 14 For N Channel HEXFETS

IRLZ24PbF

TO-220AB Package Outline



Dimensions are shown in millimeters (inches)



- NOTES:
- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
 - 2 DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
 - 3 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
 - 4 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 - 5 DIMENSION b1 & c1 APPLY TO BASE METAL ONLY.
 - 6 CONTROLLING DIMENSION ; INCHES.
 - 7 THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
 - 8 DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.

LEAD ASSIGNMENTS

- HEXFET**
- 1- GATE
 - 2- DRAIN
 - 3- SOURCE

IGBTs, CoPACK

- 1- GATE
- 2- COLLECTOR
- 3- EMITTER

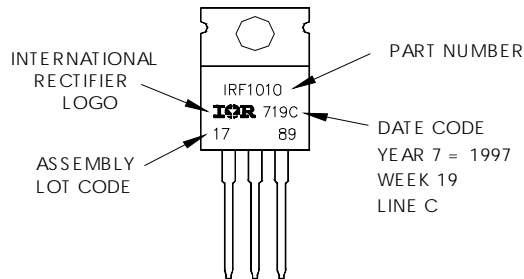
DIODES

- 1.- ANODE/OPEN
- 2.- CATHODE
- 5.- ANODE

| SYMBOL | DIMENSIONS | | | | NOTES |
|--------|-------------|-------|----------|------|-------|
| | MILLIMETERS | | INCHES | | |
| | MIN. | MAX. | MIN. | MAX. | |
| A | 3.56 | 4.82 | .140 | .190 | |
| A1 | 0.51 | 1.40 | .020 | .055 | |
| A2 | 2.04 | 2.92 | .080 | .115 | |
| b | 0.38 | 1.01 | .015 | .040 | |
| b1 | 0.38 | 0.96 | .015 | .038 | 5 |
| b2 | 1.15 | 1.77 | .045 | .070 | |
| b3 | 1.15 | 1.73 | .045 | .068 | |
| c | 0.36 | 0.61 | .014 | .024 | |
| c1 | 0.36 | 0.56 | .014 | .022 | 5 |
| D | 14.22 | 16.51 | .560 | .650 | 4 |
| D1 | 8.38 | 9.02 | .330 | .355 | |
| D2 | 12.19 | 12.88 | .480 | .507 | 7 |
| E | 9.66 | 10.66 | .380 | .420 | 4,7 |
| E1 | 8.38 | 8.89 | .330 | .350 | 7 |
| e | 2.54 BSC | | .100 BSC | | |
| e1 | 5.08 | | .200 BSC | | |
| H1 | 5.85 | 6.55 | .230 | .270 | 7,8 |
| L | 12.70 | 14.73 | .500 | .580 | |
| L1 | - | 6.35 | - | .250 | 3 |
| ØP | 3.54 | 4.08 | .139 | .161 | |
| Ø | 2.54 | 3.42 | .100 | .135 | |
| | 90°-93° | | 90°-93° | | |

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
 LOT CODE 1789
 ASSEMBLED ON WW 19, 1997
 IN THE ASSEMBLY LINE "C"
Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.



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 TAC Fax: (310) 252-7903
 12/04



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